

ORGANIC SEMICONDUCTOR INVERTING CIRCUIT

Background

5 Organic circuits are being investigated because of their promise of providing very low cost circuits for such uses as identification tags, electronic bar codes, and indicators. The low cost arises from their operational characteristics as semiconductors when formed in an amorphous material
10 state, which can be achieved by printing techniques similar to those in wide use today for passive graphic arts and membrane printing (e.g. gravure, flexography, intaglio, screen printing, micro dispensing, micro contact printing, and lithographic printing). However, the present state of printed circuit electronics introduces limitations for circuitry design. The most severe
15 limitations of printed organic electronics are: low on/off ratio (100 to 10,000), significantly large positive threshold voltage (that cannot be controlled by doping, as it typically is in inorganic circuits), and p-channel FETs only (n-channel FETs are not presently compatible with printing technologies). Such limitations are not usually addressed in the art of crystalline and semi-
20 crystalline semiconductors, because such issues are virtually unknown in conventional semiconductor technologies. Due to the present limitations of organic semiconductor devices, conventional circuit design rules (e.g., CMOS logic) cannot be directly applied. For example, two-transistor p-channel inverter designs are not known that result in useful logic circuitry because voltage
25 inputs and outputs are not compatible with one another.

Brief Description of the Drawings

30 The present invention is illustrated by way of example and not limitation in the accompanying figures, in which like references indicate similar elements, and in which:

FIGS. 1-4 are electrical schematic diagrams that show organic semiconductor inverting circuits (OSICs), in accordance with embodiments of the present invention;

FIG. 5 is a graph that shows plots of exemplary curves obtained by testing samples of OSICs, in accordance with embodiments of the present invention;

5 **FIG. 6** is a graph that shows plots of exemplary curves obtained by testing a sample of an OSIC, in accordance with a first embodiment of the present invention; and

FIG. 7 is an electrical schematic that shows a ring oscillator, in accordance with an embodiment of the present invention.

10 Skilled artisans will appreciate that elements in the figures are illustrated for simplicity and clarity and have not necessarily been drawn to scale. For example, the dimensions of some of the elements in the figures may be exaggerated relative to other elements to help to improve understanding of embodiments of the present invention.

15

Detailed Description of the Drawings

Before describing in detail the particular organic semiconductor inverting circuit in accordance with the present invention, it should be observed
20 that the present invention resides primarily in combinations of apparatus components related to organic semiconductor inverting circuitry. Accordingly, the apparatus components have been represented where appropriate by conventional symbols in the drawings, showing only those specific details that are pertinent to understanding the present invention so as not to obscure the
25 disclosure with details that will be readily apparent to those of ordinary skill in the art having the benefit of the description herein.

Referring to **FIG. 1**, an electrical schematic diagram shows an organic semiconductor inverting circuit (OSIC) **100**, in accordance with a first
embodiment of the present invention. The OSIC **100** comprises three organic
30 transistors (OTs) **101**, **102**, **103**, an input terminal **105**, and an output terminal **110**. OT **101** is an input transistor that has a gate coupled to the input terminal **105**; a first electrode coupled to a gate and a second electrode of OT **102**, to a first electrode of OT **103**, and to the output terminal **110**; and a second electrode coupled to a first positive supply voltage input **120** to which may be

applied a voltage of value $+V_{P1}$. The OT **102** has a first electrode coupled to a negative supply voltage input **125** to which may be applied a voltage of value $-V_N$. The OT **103** has a gate coupled to a second positive supply voltage input **130** to which may be applied a voltage of value $+V_{P2}$ and a second electrode coupled to a reference supply voltage input **115** (to which is applied a voltage which is the reference for the other supply voltages, and which is also referred to as a ground of the OSIC **100**). The absolute values of the voltages applied to the first and second positive supply voltage inputs **120**, **130** and negative supply voltage input **125** may be equivalent, but they are not necessarily equivalent. In a first variation of the first embodiment, the first positive supply voltage and the negative supply voltage have the same absolute value ($|-V_N| = |+V_{P1}|$). In a second variation of the first embodiment the second positive supply voltage input **130** is the same as the reference supply voltage input **115**. In a third variation of the first embodiment, there is no second positive supply voltage **130** input and the gate of OT **103** is coupled to the first positive supply voltage input **120**.

Referring to **FIG. 2**, an electrical schematic diagram shows an organic semiconductor inverting circuit (OSIC) **200**, in accordance with a second embodiment of the present invention. The OSIC **200** comprises four organic transistors (OTs) **201**, **202**, **203**, **204**, an input terminal **205**, and an output terminal **210**. OT **201** is an input transistor that has a gate coupled to the input terminal **205** and to a gate of OT **203**; a first electrode coupled to a gate and a second electrode of OT **202** and to a gate of OT **204**; and a second electrode coupled to a reference supply voltage input **215** (that is also referred to as a ground of the OSIC **200**). The OT **202** and the OT **204** have first electrodes coupled to a negative supply voltage input **220** to which may be applied a voltage of value $-V_N$. The OT **203** has a second electrode coupled to a positive supply voltage input **225** to which may be applied a voltage of value $+V_P$. The absolute values of the positive and negative supply voltages, $+V_P$ and $-V_N$, may be equivalent, but are not necessarily equivalent.

Referring to **FIG. 3**, an electrical schematic diagram shows an organic semiconductor inverting circuit (OSIC) **300**, **350** in accordance with third and fourth embodiments of the present invention. The OSIC **300** comprises four organic transistors (OTs) **301**, **302**, **303**, **304**, an input terminal **305**, and an

output terminal **310**. OT **301** is an input transistor that has a gate coupled to the input terminal **305** and to a gate of OT **303**; a first electrode coupled to a gate and a second electrode of OT **302**, to a gate and first electrode of OT **304**; and a second electrode coupled to a reference supply voltage input **315** (also referred to as a ground of the OSIC **300**). The OT **302** has a first electrode coupled to a negative supply voltage input **320** to which may be applied a voltage of value $-V_N$. The OT **303** has a second electrode coupled to a positive supply voltage input **325** to which may be applied a voltage of value $+V_P$. The OT **303** has a first electrode coupled to a second electrode of OT **304** and to the output **310**. The absolute values of the positive and negative supply voltages, $+V_P$ and $-V_N$, may be equivalent, but are not necessarily equivalent.

The OSIC **350** comprises four organic transistors (OTs) **301**, **302**, **303**, **304**, an input terminal **305**, and an output terminal **311**. The OSIC **350** differs from the OSIC **300** in that the output terminal **311** is coupled to a node that includes the gate and first electrode of OT **304** and the gate and second electrode of OT **302**. Furthermore, there is no output at the node of the first electrode of OT **303** and the second electrode of OT **304**.

Referring to **FIG. 4**, an electrical schematic diagram shows an organic semiconductor inverting circuit (OSIC) **400**, **450** in accordance with fifth and sixth embodiments of the present invention. The OSIC **400** comprises four organic transistors (OTs) **401**, **402**, **403**, **404**, an input terminal **405**, and an output terminal **410**. OT **401** is an input transistor that has a gate coupled to the input terminal **405** and to a gate of OT **403**; a first electrode coupled to a gate and a second electrode of OT **402**, to a first electrode of OT **404**; and a second electrode coupled to a reference supply voltage input **415** (also referred to as a ground of the OSIC **400**). The OT **402** has a first electrode coupled to a negative supply voltage input **420** to which may be applied a voltage of value $-V_N$. The OT **403** has a second electrode coupled to a positive supply voltage input **425** to which may be applied a voltage of value $+V_P$. The OT **403** has a first electrode coupled to a gate and second electrode of OT **404** and to the output **410**. The absolute values of the positive and negative supply voltages, $+V_P$ and $-V_N$, may be equivalent, but are not necessarily equivalent.

The OSIC **450** comprises four organic transistors (OTs) **401**, **402**, **403**, **404**, an input terminal **405**, and an output terminal **411**. The OSIC **450** differs

from the OSIC **400** in that the output terminal **411** is coupled to a node that includes the first electrode of OT **404** and the gate and second electrode of OT **402**. Furthermore, there is no output at the node of the first electrode of OT **403** and the gate and second electrode of OT **404**.

5 The organic semiconductor inverting circuits **100, 200, 300, 350, 400, 450** comprise the following elements in common:

 at least three organic transistors, one of which is an input transistor having a gate to which is coupled an input terminal;

 an output terminal coupled to a first electrode of at least one of the at least three organic transistors;

 a reference supply voltage input coupled to a second electrode of at least one of the at least three organic transistors;

 a first positive supply voltage input coupled to a second electrode of at least one of the at least three organic transistors; and

15 a negative supply voltage input coupled to a first electrode of at least one of the at least three organic transistors.

 Samples of the organic semiconductor inverting circuits **100, 200, 300, 350, 400, 450** were designed and built using organic transistors most representative of current printed (non-vacuum) manufacturable technology. Selected circuits were aged for a minimum of 1 month in a dry box under a nitrogen atmosphere. Device technology that was the most repeatable as well as the most stable over time was selected for circuit design and fabrication. The technology used consists of screen-printed dielectric and source-drain elements on top of a copper print/etch gate electrode on a polyester substrate. Alternatively, the copper gate print/etch layer can be substituted with a screen-printed gate element. The organic semiconductor material was deposited by non-contact micro dispensing. This device technology has shown stability in a dry nitrogen atmosphere for over 3-4 months without any protective barrier materials, while exhibiting predictable and repeatable electrical performance. Device behavior was also repeatable over time and from device-to-device.

 The selection of OT geometry of the samples was based on readily available devices, using geometries compatible with high-throughput print techniques. Available geometries for the channel length, L , and channel width, W , were $L = \{0.10, 0.15, 0.20, 0.30\}$ mm, and $W = \{2.5, 5.0\}$ mm. Device

channel widths were held constant at $W = 5.0$ mm as channel length was modified.

Whenever practical, the same devices were repeatedly used for each series of tests. Devices were interconnected using copper wire and standard
5 Sn-Pb solder, attached to the copper test pads on each device.

All tests were conducted in the dark (using a dark box) and under ambient conditions (room temperature, pressure, and humidity). For each test, device temperature and sample chamber humidity were recorded. No
10 significant changes in device behavior were observed for the recorded changes in either temperature or humidity during test.

The OT devices designed and fabricated in accordance with the embodiments of the present invention described above are p -channel devices that may be switched on with negative supply voltages, but typically require significantly positive voltages to fully switch off (due to a positive threshold
15 voltage). A split supply was used for optimal circuit performance. A symmetrical split supply having $|+V_P| = |-V_N|$ was used for testing OSICs **200, 300, 350, 400, and 450**. Although a symmetrical split supply may be less desirable than a single supply, it has advantages over other multiple-voltage alternatives. One advantage of a symmetrical split supply is realized at the product level for some
20 indicator technologies, where a reversal of supply polarity voltage is necessary to switch the state of an indicator. Such indicator technologies include electrochromics, electrophoretics, and cholesterics. Therefore, the use of a symmetrical supply may be a preferred option for product-level design.

The optimization of device geometry is crucial for proper inverter
25 operation due to the relatively low on/off ratio (100 to 10,000) of OTs fabricated using currently available materials. It is desirable to select the geometries of the devices so that adequate voltage division is achieved throughout the full range of input voltages in order to obtain useful output values, while maintaining other desirable circuit attributes, such as high inverter gain.

30 From the experiments conducted with the organic semiconductor inverting circuits **200, 300, 350, 400, 450** using $-V_N = -100$ volts and $+V_P = 100$ volts, the following general conclusions were drawn.

1) When OT **201, 301, 401** has sufficient channel resistance, the output **210, 310, 311, 410, 411** may be held at adequately positive voltages. In some

examples, it was found that when the channel length of OT **201, 301, 401** was 0.3 mm (creating a relatively resistive path), the output was able to swing very close to $+V_P$ when a negative voltage was applied to the organic semiconductor inverting circuit input **205, 305, 405**.

5 2) A balanced channel resistance may be preferable for OT **202, 302, 402**, as excessively low or excessively high channel resistances appear to have a detrimental effect on performance in some applications. When the channel is too conductive (e.g., channel length is 0.1 mm), the output **210, 310, 311, 410, 411** may not be able to swing sufficiently towards $+V_P$, plus the
10 inverter gain may be significantly reduced. When the channel resistance is too large, the transition from positive to negative output occurs at relatively high positive input voltages (transitions have been shown to occur when the input voltage is only a few volts more negative than $+V_P$). Additionally, the output is unable to swing negative at all, and inverter gain is significantly reduced.

15 3) It may be preferable for OT **203, 303, 403** to be the most resistive OT (i.e., have the highest channel resistance). Since the second electrode of OT **203, 303, 403** is tied to $+V_P$, the gate is always more negative than the voltage at the second electrode. Therefore, OT **203, 303, 403** will tend to always be on to some degree (due to the significantly positive threshold voltages). When OT
20 **203, 303, 403** is not sufficiently resistive, the inverter may fail to pull the output to negative values. With insufficient channel resistance in OT **203, 303, 403**, the output **210, 310, 311, 410, 411** may not be held negative when the input voltage drops below about $0.5 \times +V_P$.

25 Samples of three primary embodiments of the four transistor organic semiconductor inverting circuits **200, (300 & 350)**, and **(400 & 450)** were tested. The difference between each of the three primary embodiments is the connection of OT **204, OT 304, OT 404**, which modifies the connection of the output of stage 1 (OT **201 & 202, OT 301 & 302, OT 401 & 402**) of the organic semiconductor inverting circuits to OT **203, 303, 403** and the output terminal
30 **210, 310, 311, 410, 411**.

Referring to FIG. 5, a graph shows plots of exemplary curves obtained by testing samples of organic semiconductor inverting circuits (OSICs), in accordance with embodiments of the present invention. Table 1 lists the OSIC

embodiments tested and the channel lengths, in millimeters, of the organic transistors tested. The channel width in all cases was 5.0 mm.

OSIC 200		OSIC 300		OSIC 350		OSIC 400		OSIC 450	
Plot 505		Plot 510		Plot 520		Plot 515		Plot 525	
OT	L(mm)	OT	L(mm)	OT	L(mm)	OT	L(mm)	OT	L(mm)
201	0.3	301	0.3	301	0.3	401	0.2	401	0.3
202	0.3	302	0.15	302	0.15	402	0.1	402	0.1
203	0.2	303	0.3	303	0.3	403	0.3	403	0.3
204	0.15	304	0.1	304	0.1	404	0.1	404	0.1

Table 1

5 Curve **505** is a plot of voltage at the output terminal **210** versus voltage at the input terminal **205** of OSIC **200**. It will be appreciated that in organic semiconductor inverting circuit **200** the output of stage 1 (OT **201** & OT **202**) is coupled to the gate electrode of OT **204**. The first electrode of OT **204** is connected to $-V_N$. Stage 1 controls the resistance of OT **204**, and along with
 10 OT **203**, results in a voltage divider circuit for the output terminal. Experiments with OSIC **200** show that the circuit exhibits inverting behavior but has a non-symmetric behavior. The performance of OSIC **200** may be more symmetric with OT devices that possess larger on/off ratios (greater than 10^4 or 10^5).

15 Curves **510**, **515** are plots of voltages at the output terminals **310**, **410** versus voltages at the input terminals **305**, **405** of OSICs **300**, **400**, with the geometries shown above. OSICs **300**, **400** are very similar in design to one another, with the first electrode of OT **304**, **404** connected to the output of stage 1 (OT **301** & OT **302**, OT **401** & OT **402**). The gate terminal of OT **304** is connected to the first electrode of OT **304** in OSIC **300**, and to the second
 20 electrode of OT **404** and output terminal **410** in OSIC **400**. In the case of OSIC **400**, the circuit structure results in two identical two-device inverters, the power supply of stage 2 (OT **403** & **404**) connected to the output of stage 1. For both OSIC **300** and OSIC **400**, the output of stage 1 is passed to the output terminal when the input terminal is positive (OT **303**, **403** at high resistance). For
 25 negative input voltage, the stage 1 output is pulled towards ground and the output is dominated by the low-resistance path to $+V_P$ through OT **303**, **403**. OT **304**, **404** acts as a load which allows a voltage drop between the stage 1

output and the output terminal, allowing the output terminal to swing positive. In OSIC 300, the resistance of OT 304 is governed by the voltage of stage 1, while in OSIC 400 this resistance is dependent on the voltage of the output terminal. Both OSIC 300 and OSIC 400 were able to deliver reasonable
 5 performance with the on/off ratios (on the order of 100 to 1000) of the first stages of the sample devices.

Curves 520, 525 are plots of voltages at the output terminals 310, 410 versus voltages at the input terminals 305, 405 of OSICs 300, 400, with the geometries shown above. OSIC 350 and OSIC 450 are electrically identical to
 10 OSICs 300, 400, respectively, except that the output terminal 311, 411 is defined as the output of stage 1. In this configuration, it was more difficult to obtain acceptable behavior for negative output voltages. This is primarily due to the lack of isolation of the output terminal from system ground, which resulted in the output terminal 311, 411 being pulled increasingly towards ground as the
 15 input voltage became more negative (as OT 301, OT 401 decreases in resistance). Good performance of OSIC 350 is achievable when the channel resistance of OT 301 is sufficiently high and the channel resistance of 302 is properly balanced, which is demonstrated by curve 520 - obtained with a
 20 channel length of 0.3 mm for OT 301 and a channel length of 0.15 mm for OT 302.

Referring to FIG. 6, a graph shows plots of exemplary curves obtained by testing a sample of organic semiconductor inverting circuit (OSIC) 100, in accordance with the first embodiment of the present invention. The performance of the OSIC 100 may be enhanced when OT 102 has a
 25 sufficiently high resistance. When the channel of OT 102 is too conductive (e.g., channel length is 0.1 mm), the output voltage does not swing sufficiently towards $+V_{P1}$, and the inverter gain is reduced. Increases in the channel resistance of OT 102 result in improved output voltage swing towards $+V_{P1}$, and improved inverter gain.

For similar reasons that high channel resistance of OT 203, 303, 403 benefits the four-transistor OSIC 200, 300, 350, 400, 450 designs, OSIC 100 typically benefits from a high channel resistance of OT 101. Since the second electrode of OT 101 is tied to $+V_{P1}$, the gate voltage of OT 101 is always more negative than the second electrode voltage. Therefore, OT 101 is normally on
 30

to some degree (due to the significantly positive threshold voltages of the OT transistors being used in these samples). When OT **101** is not sufficiently resistive, the OSIC **100** will fail to pull the output voltage to negative values.

5 The channel resistance for OT **103** was chosen to be highly resistive (channel length of 0.3 mm) in order to minimize power supply current drain. Note that a channel resistance of OT **103** that is too low may cause the output to not be able to swing sufficiently towards either $+V_{P1}$ or $-V_N$.

For the sample OSIC **100** used to obtain the plots in FIG. 6, the channel widths of OT **101**, OT **102**, and OT **103** were all 5.0 mm. The channel length of
 10 OT **101** was 0.2 mm, the channel length of OT **102** was 0.1 mm, and the channel length of OT **103** was 0.3 mm. The first positive supply voltage, $+V_{P1}$, and the negative supply voltage, $-V_N$, were fixed at +75 volts and -75 volts, respectively. Plots of voltages measured at output terminal **110** versus voltages applied at input terminal **105** were taken for a set of second positive voltages,
 15 V_{P2} , ranging from -75 volts to +75 volts. When V_{P2} is at -5 volts, it can be seen that the transition from a positive output voltage to a negative output voltage (which is the offset) occurs with approximately +7 volts at the input terminal **105**. The absolute gain at this transition point is on the order of 3. The performance of the sample OSIC **100** when $+V_{P2}$ is tied to the reference supply
 20 voltage, which is one variant of OSIC **100** described above, can be inferred by interpolating between the plots for $+V_{P2} = -5$ volts and $+V_{P2} = +5$ volts. The performance of the sample OSIC **100** when $+V_{P2}$ is tied to $+V_{P1}$, which is another variant of OSIC **100** described above, can be inferred from the plot for $+V_{P2} = +75$ volts. From these plots, it will be appreciated that OSIC **100**
 25 provides a usable inversion of the input signal when $+V_{P2}$ is tied to the reference supply voltage.

Referring to FIG. 7, an electrical schematic shows a ring oscillator **700**, in accordance with an embodiment of the present invention. The ring oscillator comprises four OSICs **701**, **702**, **703**, **704**, each of which is an OSIC **400** as
 30 described above. Three of the OSICs **701**, **702**, **703** are coupled in a series ring (the output terminal **410** of each of three of the OSICs **701**, **702**, **703** is coupled to the input terminal **405** of the next OSIC in the ring), and a fourth OSIC **703** coupled to an output terminal **410** of one of the three OSICs **701**, **702**, **703** in the series ring. The input terminal **405** of the OSIC **701** forms an

input terminal of the ring oscillator **700**, and the output terminal **410** of the OSIC **704** forms an output terminal of the ring oscillator **700**. A test circuit was constructed in which the channel lengths of OT **401**, OT **402**, OT **403**, OT **404** of each OSIC in the ring oscillator **700** were, respectively, 0.2 mm, 0.15 m, 0.3 mm, and 0.1 mm, and the channel widths were all 5.0 mm. The positive supply voltage, $+V_P$, and the negative supply voltage, $-V_N$, were +100 volts and -100 volts, respectively. This ring oscillator **700** therefore comprises an OSIC **400** having a selected channel material and a set of channel geometries, wherein the transfer characteristics of the OSIC **400** are such that a ring oscillator circuit operation is obtained using the OSIC **400** with a plurality of OSICs **400** having essentially identical channel material and channel geometry.

A similar ring oscillator test circuit was constructed using four OSICs **100** (not shown in FIGS. 1-7) similarly intercoupled, in which the channel lengths of OT **101**, OT **102**, OT **103** were, respectively, 0.3 mm, 0.15 m, and 0.3 mm, and the channel widths were all 5.0 mm. The first positive supply voltage, $+V_{P1}$, the second positive supply voltage, $+V_{P2}$, and the negative supply voltage, $-V_N$, were +75 volts, +75 volts, and -75 volts, respectively. Both ring oscillators were self-starting. The ring oscillator **700** constructed of OSICs **400** oscillated at a frequency of approximately 0.01 Hz. The ring oscillator constructed of OSICs **100** oscillated at a frequency of approximately 0.02 Hz. It will be appreciated that other ring oscillators could be constructed comprising an odd number of OSICs selected from the OSICs **100**, **200**, **300**, **350**, **400**, **450** described herein, coupled in a series ring, wherein the geometries are selected to provide transfer characteristics that ensure compatible inputs and outputs.

It will be appreciated by now that a variety of organic semiconductor inverting circuits have been described that generate an input to output signal inversion that is satisfactory for use in a ring oscillator, and may be used with other logic circuits such as NAND, NOR, AND, and OR circuits to form other logic functions. Level shifting circuits may be used with other logic circuits, either organic or inorganic, to adapt the inputs and outputs of the OSICs **100**, **200**, **300**, **350**, **400**, **450** to logic technologies having different characteristics. The logic functions thus formed may provide any of the wide variety of logic

functions in current use, within limits imposed by the volume and speed of the organic transistors.

In the foregoing specification, the invention and its benefits and advantages have been described with reference to specific embodiments.

5 However, one of ordinary skill in the art appreciates that various modifications and changes can be made without departing from the scope of the present invention as set forth in the claims below. Accordingly, the specification and figures are to be regarded in an illustrative rather than a restrictive sense, and all such modifications are intended to be included within the scope of present
10 invention. The benefits, advantages, solutions to problems, and any element(s) that may cause any benefit, advantage, or solution to occur or become more pronounced are not to be construed as a critical, required, or essential features or elements of any or all the claims.

As used herein, the terms "comprises," "comprising," or any other
15 variation thereof, are intended to cover a non-exclusive inclusion, such that a process, method, article, or apparatus that comprises a list of elements does not include only those elements but may include other elements not expressly listed or inherent to such process, method, article, or apparatus. The terms
"including" and/or "having", as used herein, are defined as comprising. The
20 term "coupled", as used herein with reference to electro-optical technology, is defined as connected, although not necessarily directly, and not necessarily mechanically.

What is claimed is: